

Application/Control No.	Applicant(s)/Patent under Reexamination	·
10/047,131	KAKU ET AL.	
Examiner	Art Unit	
Sam K. Ahn	2611	

SEARCHED						
Class	Subclass	Date	Examiner			
3715	135,144 240.19 240.19 267,295	y10 3/20	a			
375	212,260,					
370	25					
714	700,701. 774,788	3/31	ar			
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EBT lowester work keyword & nifetin semble 1000 & angle beyword stouch	3/28	a	
CONSULTED WITH SPE Chich Fan (775) P.E. Pocure Tr. Feldet (375) P.E. Andy Lee (370)	3/31	an	
TAT, IEEE & Google updated keyword & citation souch	8/1 s/1	88	